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(MIZUSHIMA,Ichiro) [JP/JP]; 〒240-0015 神奈川県 横浜市保土ヶ谷区 岩崎町 20-1-307 Kanagawa

(JP).

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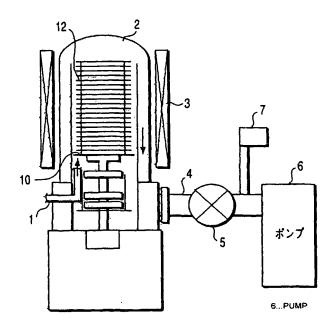
(71) 出願人(米国を除く全ての指定国について): 株式会 社 東芝 (KABUSHIKI KAISHA TOSHIBA) [JP/JP]; 〒 105-8001 東京都港区 芝浦一丁目 1番 1号 Tokyo (JP). 添付公開書類: 国際調査報告書

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(54) Title: PURGING METHOD FOR SEMICONDUCTOR PRODUCTION DEVICE AND PRODUCTION METHOD FOR SEMICONDUCTOR DEVICE

(54) 発明の名称: 半導体製造装置のパージ方法及び半導体装置の製造方法



(57) Abstract: A purging method for a semiconductor production device comprising the step of etching, by a cleaning gas containing at least halogen gas, a CVD deposit film deposited in a chamber (2) constituting a semiconductor production device that has formed a CVD film on a semiconductor wafer (12) by a CVD method, and the step of purging, after the step of etching the above CVD deposit film by a cleaning gas, a cleaning gas remaining in the chamber (2) by passing a hydrogen-containing gas through the chamber (2).

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# WO 03/019634RNATIONAL SEARCH REPORT

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A. CLASSIFICATION OF SUBJECT MATTER Int.Cl <sup>7</sup> H01L21/205, C23C16/44				
According to International Patent Classification (IPC) or to both national classification and IPC				
B. FIELDS SEARCHED				
Minimum de	ocumentation searched (classification system followed C1 H01L21/205, 21/306, 21/306	by classification symbols)		
Inc.	CI HUILZI/2U3, 21/300, 21/300	55, C23C16/44		
Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched				
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Electronic d	ata base consulted during the international search (nam	ne of data base and, where practicable, sea	rch terms used)	
C. DOCUI	MENTS CONSIDERED TO BE RELEVANT			
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considered to be of particular relevance understand the principle or theory underlying the invention				
date considered novel or cannot be considered to involve an inventive				
cited to establish the publication date of another citation or other "Y" document of particular relevance; the claimed invention cannot be				
special reason (as specified) considered to involve an inventive step when the document is document referring to an oral disclosure, use, exhibition or other combined with one or more other such documents, such				
means  "P" document published prior to the international filing date but later than the priority date claimed  "Combination being obvious to a person skilled in the art document member of the same patent family				
Date of the actual completion of the international search 26 November, 2002 (26.11.02)  Date of mailing of the international search report 10 December, 2002 (10.12.02)				
26 N	ovember, 2002 (26.11.02)	10 December, 2002 (	10.12.02)	
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Japanese Patent Office				
Facsimile No.		Telephone No.		

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# INTERNATIONAL SEARCH REPORT

International application No.
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